

Notice of References Cited	Application/Control No. 10/666,117	Applicant(s)/Patent Under Reexamination TAKAIWA ET AL.	
	Examiner Kelly L. Jerabek	Art Unit 2622	Page 1 of 1

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*	B US-6,674,472	01-2004	Tsutsui, Satoru	348/333.05
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NON-PATENT DOCUMENTS

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